


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542867	<b>Applicant(s)/Patent Under Reexamination</b>  SHINODA ET AL.
	<b>Examiner</b>  JAE W LEE, PhD	<b>Art Unit</b>  1656

### SEARCHED

Class	Subclass	Date	Examiner
NONE	NONE	3/5/2008	JWL

### SEARCH NOTES

Search Notes	Date	Examiner
NPL searched, see attached history	3/5/2008	JWL
East, see attached history including inventor name search	3/5/2008	JWL
See search results available by SCORE	3/5/2008	JWL
PALM inventor name search	3/5/2008	JWL

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner